

# DATA SHEET

**74AC373/74ACT373**

Octal D-type transparent latch (3-State)

Product specification

1997 Apr 07

## Octal D-type transparent latch (3-State)

74AC373  
74ACT373

## FEATURES

- 74ACT373 has TTL-compatible inputs
- 74AC373 has CMOS-compatible inputs
- 3-State outputs source/sink 24mA
- 3-State outputs drive bus lines or buffer memory address registers
- Meets or exceeds JEDEC standard for 74AC(T)XX family
- Superior ground bounce noise immunity

## DESCRIPTION

The 74AC373/74ACT373 is an octal D-type transparent latch featuring separate D-type inputs for each latch and 3-State outputs for bus oriented applications. A latch enable (LE) input and an output enable ( $\overline{OE}$ ) input are common to all internal latches.

The '373' consists of eight D-type transparent latches with 3-State true outputs. When LE is HIGH, data at the  $D_n$  inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change each time its corresponding D-input changes.

When LE is LOW the latches store the information that was present at the D-inputs a set-up time preceding the HIGH-to-LOW transition of LE. When  $\overline{OE}$  is LOW, the contents of the eight latches are available at the outputs. When  $\overline{OE}$  is HIGH, the outputs go to the high impedance OFF-state. Operation of the  $\overline{OE}$  input does not affect the state of the latches.

The '373' is functionally identical to the '573', but the '573' has a different pin arrangement.

## QUICK REFERENCE DATA

GND = 0V;  $T_{amb} = 25^\circ\text{C}$ ;  $t_r = t_f \leq 2.5$  ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL			UNIT
			AC		ACT	
			$V_{CC} = 3.3\text{V}$	$V_{CC} = 5.0\text{V}$	$V_{CC} = 5.0\text{V}$	
$t_{PHL}/t_{PLH}$	Propagation delay Dn to Qn; LE to Qn	$C_L = 50\text{pF}$	4.9 5.5	3.6 3.8	4.6 4.8	ns
$C_I$	Input capacitance		4.5			pF
$C_{PD}$	Power dissipation capacitance	$V_{in} = \text{GND to } V_{CC}^1$ outputs enabled <sup>2</sup> outputs enabled <sup>3</sup> outputs disabled <sup>2</sup> outputs disabled <sup>3</sup>	24 84 14 23		28 86 15 30	pF

## NOTES:

- $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ )  
 $P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o)$  where:  
 $f_i$  = input frequency in MHz;  $C_L$  = output load capacity in pF;  
 $f_o$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;  
 $\sum (C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.
- Switch the latch enable and one data input such that one latch toggles
- Switch the latch enable and all data inputs such that all latches toggle

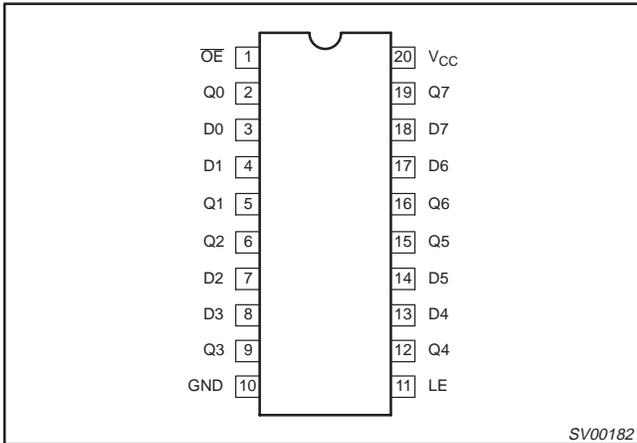
## ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
20-Pin Plastic SO	-40°C to +85°C	74AC373 D 74ACT373 D	74AC373 D 74ACT373 D	SOT163-1
20-Pin Plastic SSOP Type II	-40°C to +85°C	74AC373 DB 74ACT373 DB	74AC373 DB 74ACT373 DB	SOT339-1
20-Pin Plastic TSSOP Type I	-40°C to +85°C	74AC373 PW 74ACT373 PW	74AC373PW DH 74ACT373PW DH	SOT360-1

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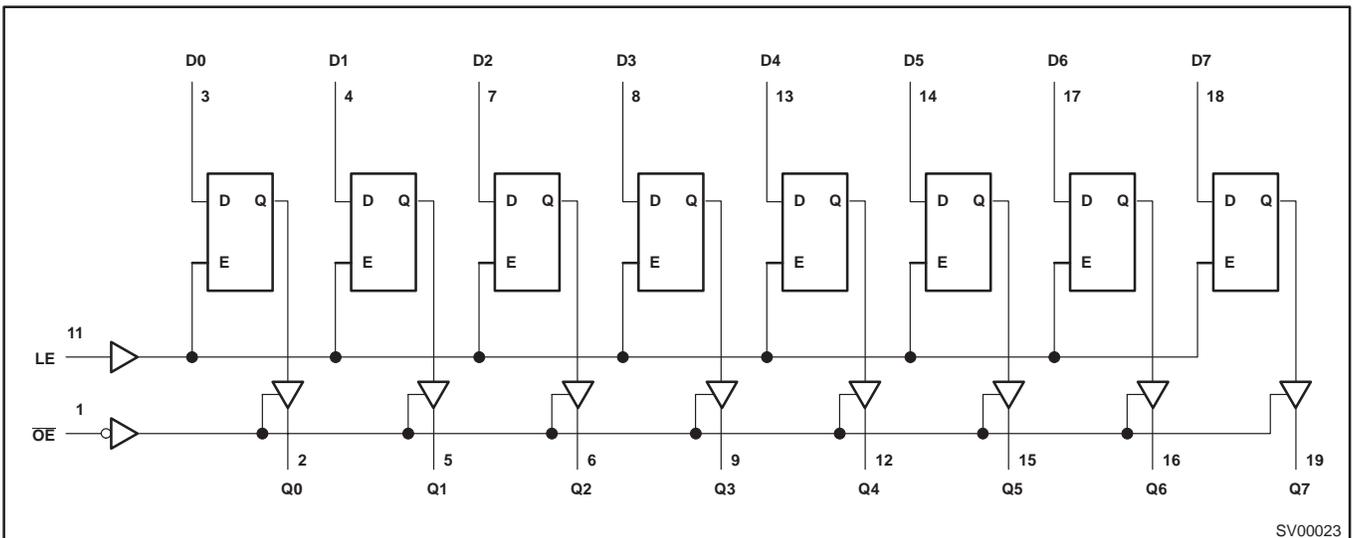
## PIN CONFIGURATION



## PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1	$\overline{OE}$	Output enable input (active-Low)
3, 4, 7, 8, 13, 14, 17, 18	D0-D7	Data inputs
2, 5, 6, 9, 12, 15, 16, 19	Q0-Q7	Data outputs
10	GND	Ground (0V)
11	LE	Latch enable input (active-High)
20	$V_{CC}$	Positive supply voltage

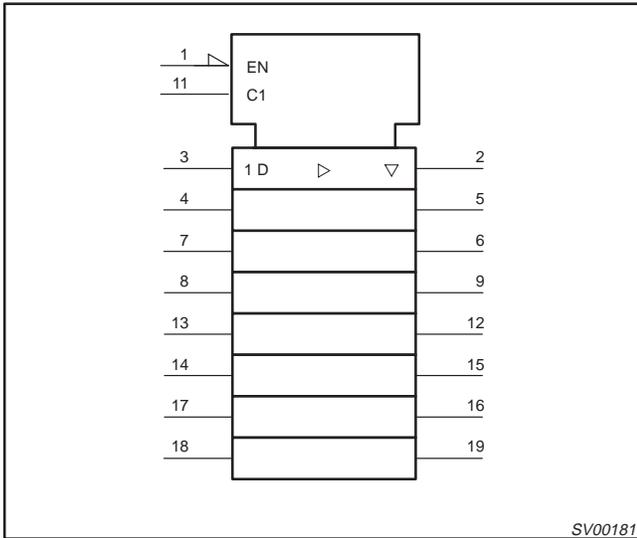
## LOGIC DIAGRAM



# Octal D-type transparent latch (3-State)

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## LOGIC SYMBOL (IEEE/IEC)



## FUNCTION TABLE

OPERATING MODES	INPUTS			INTERNAL LATCHES	OUTPUTS
	OE	LE	D <sub>n</sub>		Q <sub>0</sub> to Q <sub>7</sub>
Enable and read register (transparent mode)	L	H	L	L	L
	L	H	H	H	H
Latch and read register	L	L	l	L	L
	L	L	h	H	H
Latch register and disable outputs	H	L	l	L	Z
	H	L	h	H	Z

- H = HIGH voltage level
- h = HIGH voltage level one setup time prior to the HIGH-to-LOW LE transition
- L = LOW voltage level
- l = LOW voltage level one setup time prior to the HIGH-to-LOW LE transition
- X = Don't care
- Z = High impedance OFF-state

## Octal D-type transparent latch (3-State)

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## RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS		UNIT
		MIN	MAX	
$V_{CC}$	DC supply voltage for 'AC	2.0	6.0	V
$V_{CC}$	DC supply voltage for 'ACT	4.5	5.5	V
$V_I$	DC input voltage range	0	$V_{CC}$	V
$V_O$	DC output voltage range	0	$V_{CC}$	V
$T_{amb}$	Operating free-air temperature range	-40	+85	°C
$\Delta V/\Delta t$	Minimum input edge rate — AC devices $V_{IN}$ from 30% to 70% of $V_{CC}$ $V_{CC}$ @ 3.3V, 4.5V, 5.5V	125		mV/ns
	— ACT devices $V_{IN}$ from 0.8V to 2.0V $V_{CC}$ @ 4.5V, 5.5V	125		

ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

in accordance with the Absolute Maximum Rating System (IEC134)  
Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
$V_{CC}$	DC supply voltage		-0.5 to +7.0	V
$I_{IK}$	DC input diode current	$V_I = -0.5V$	-20	mA
		$V_I = V_{CC} + 0.5V$	+20	
$V_I$	DC input voltage		-0.5 to $V_{CC} + 0.5$	V
$I_{OK}$	DC output diode current	$V_O = -0.5V$	-20	mA
		$V_O = V_{CC} + 0.5V$	+20	
$V_O$	DC output voltage		-0.5 to $V_{CC} + 0.5$	V
$I_O$	DC output source or sink current		± 50	mA
$I_{CC}, I_{GND}$	DC $V_{CC}$ or GND current per output		± 50	mA
$I_{CC}, I_{GND}$	DC $V_{CC}$ or GND current		± 200	mA
$T_{stg}$	Storage temperature range		-65 to 150	°C
$P_{TOT}$	Power dissipation per package — plastic mini-pack (SO) — plastic shrink mini-pack (SSOP and TSSOP)	above +70°C derate linearly with 8 mW/K	500	mW
		above +60°C derate linearly with 5.5 mW/K	500	

## NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## Octal D-type transparent latch (3-State)

74AC373  
74ACT373**DC ELECTRICAL CHARACTERISTICS (74AC373)**

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	V <sub>CC</sub> (V)	LIMITS			UNIT	
				Temp = -40°C to +85°C				
				MIN	TYP <sup>1</sup>	MAX		
V <sub>IH</sub>	HIGH level Input voltage	V <sub>OUT</sub> = 0.1V or (V <sub>CC</sub> - 0.1V)	3.0	2.1	1.5		V	
			4.5	3.15	2.25			
			5.5	3.85	2.75			
V <sub>IL</sub>	LOW level Input voltage	V <sub>OUT</sub> = 0.1V or (V <sub>CC</sub> - 0.1V)	3.0		1.5	0.9	V	
			4.5		2.25	1.35		
			5.5		2.75	1.65		
V <sub>OH</sub>	HIGH level output voltage	I <sub>OUT</sub> = -50 μA	3.0	2.9	2.99		V	
			4.5	4.4	4.49			
			5.5	5.4	5.49			
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OH</sub> = -12mA <sup>1</sup>	3.0	2.46			V
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OH</sub> = -24mA <sup>1</sup>	4.5	3.76			
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OH</sub> = -24mA <sup>1</sup>	5.5	4.76			
V <sub>OL</sub>	LOW level output voltage	I <sub>OUT</sub> = 50 μA	3.0		0.01	0.1	V	
			4.5		0.01	0.1		
			5.5		0.01	0.1		
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OL</sub> = 12mA <sup>1</sup>	3.0			0.44	V
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OL</sub> = 24mA <sup>1</sup>	4.5			0.44	
			V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OL</sub> = 24mA <sup>1</sup>	5.5			0.44	
I <sub>IN</sub>	Input leakage current	V <sub>IN</sub> = V <sub>CC</sub> , GND	5.5			±1.0	μA	
I <sub>OZ</sub>	3-State output OFF-state current	V <sub>IN</sub> (OE) = V <sub>IL</sub> , V <sub>IH</sub> V <sub>IN</sub> = V <sub>CC</sub> , GND V <sub>OUT</sub> = V <sub>CC</sub> , GND	5.5			±2.5	μA	
I <sub>OLD</sub> <sup>2</sup>	Dynamic output current <sup>2</sup>	V <sub>OLD</sub> = 1.65V max	5.5	75			mA	
I <sub>OHD</sub> <sup>2</sup>	Dynamic output current <sup>2</sup>	V <sub>OHD</sub> = 3.85V min	5.5			-75	mA	
I <sub>CC</sub>	Quiescent supply current	V <sub>IN</sub> = V <sub>CC</sub> or GND	5.5			40	μA	

**NOTES:**

- All outputs loaded
- Maximum test duration 2.0 ms; one output loaded at a time

## Octal D-type transparent latch (3-State)

74AC373  
74ACT373**DC ELECTRICAL CHARACTERISTICS (74ACT373)**

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	V <sub>CC</sub> (V)	LIMITS			UNIT
				Temp = -40°C to +85°C			
				MIN	TYP <sup>1</sup>	MAX	
V <sub>IH</sub>	HIGH level Input voltage	V <sub>OUT</sub> = 0.1V or (V <sub>CC</sub> - 0.1V)	4.5	2.0	1.5		V
			5.5	2.0	1.5		
V <sub>IL</sub>	LOW level Input voltage	V <sub>OUT</sub> = 0.1V or (V <sub>CC</sub> - 0.1V)	4.5		1.5	0.8	V
			5.5		1.5	0.8	
V <sub>OH</sub>	HIGH level output voltage	I <sub>OUT</sub> = -50 μA	4.5	4.4	4.49		V
			5.5	5.4	5.49		
		V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OH</sub> = -24mA <sup>1</sup>	4.5	3.76			V
			5.5	4.76			
V <sub>OL</sub>	LOW level output voltage	I <sub>OUT</sub> = 50 μA	4.5		0.01	0.1	V
			5.5		0.01	0.1	
		V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> , I <sub>OL</sub> = 24mA <sup>1</sup>	4.5			0.44	V
			5.5			0.44	
I <sub>IN</sub>	Input leakage current	V <sub>IN</sub> = V <sub>CC</sub> , GND	5.5			±1.0	μA
I <sub>OZ</sub>	3-State output OFF-state current	V <sub>IN</sub> (OE) = V <sub>IL</sub> , V <sub>IH</sub> V <sub>IN</sub> = V <sub>CC</sub> , GND V <sub>OUT</sub> = V <sub>CC</sub> , GND	5.5			±2.5	μA
ΔI <sub>CC</sub>	Additional quiescent supply current per input pin	V <sub>IN</sub> = V <sub>CC</sub> - 2.1V Other inputs at V <sub>CC</sub> or GND; I <sub>OUT</sub> = 0	5.5			1.5	mA
I <sub>OLD</sub> <sup>2</sup>	Dynamic output current	V <sub>OLD</sub> = 1.65V max	5.5	75			mA
I <sub>OHD</sub> <sup>2</sup>	Dynamic output current	V <sub>OHD</sub> = 3.85V min	5.5			-75	mA
I <sub>CC</sub>	Quiescent supply current	V <sub>IN</sub> = V <sub>CC</sub> or GND	5.5			40	μA

**NOTES:**

1. All outputs loaded
2. Maximum test duration 2.0ms, one output loaded at a time

## Octal D-type transparent latch (3-State)

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74ACT373**AC CHARACTERISTICS FOR 74AC373**GND = 0V;  $t_R = t_F = 2.5\text{ns}$ ;  $C_L = 50\text{pF}$ ;  $R_L = 500\Omega$ ; .

SYMBOL	PARAMETER	$V_{CC}^1$ (V)	LIMITS					UNIT	WAVEFORM
			$T_{amb} = +25^\circ\text{C}$			$T_{amb} = -40^\circ\text{C to } +85^\circ\text{C}$			
			MIN	TYP	MAX	MIN	MAX		
$t_{PLH}$	Propagation delay $D_n$ to $Q_n$	3.3 5.0	2.0 1.5	5.1 3.6	12.5 9.5	1.5 1.0	14.5 10.5	ns	2
$t_{PHL}$	Propagation delay $D_n$ to $Q_n$	3.3 5.0	2.0 1.5	5.1 3.6	12.5 9.5	1.5 1.0	14.5 10.5	ns	2
$t_{PLH}$	Propagation delay LE to $Q_n$	3.3 5.0	2.0 1.5	5.6 3.9	12.5 9.5	1.5 1.0	14.5 10.5	ns	1
$t_{PHL}$	Propagation delay LE to $Q_n$	3.3 5.0	2.0 1.5	5.4 3.8	12.5 9.5	1.5 1.0	14.5 10.5	ns	1
$t_{PZH}$	3-State output enable time $\overline{OE}$ to $Q_n$	3.3 5.0	2.0 1.5	5.9 4.0	11.0 8.5	1.5 1.0	13.0 9.5	ns	4
$t_{PZL}$	3-State output enable time $\overline{OE}$ to $Q_n$	3.3 5.0	2.0 1.5	5.9 4.2	11.0 8.5	1.5 1.0	13.0 9.5	ns	4
$t_{PHZ}$	3-State output disable time $\overline{OE}$ to $Q_n$	3.3 5.0	2.0 1.5	5.1 3.5	10.5 8.0	1.5 1.0	12.0 9.0	ns	4
$t_{PLZ}$	3-State output disable time $\overline{OE}$ to $Q_n$	3.3 5.0	2.0 1.5	4.6 3.3	10.5 8.0	1.5 1.0	12.0 9.0	ns	4
$t_w$	LE pulse width HIGH	3.3 5.0	5.5 4.0	2.0 1.5		6.0 4.5		ns	1
$t_{su}$	Set up time $D_n$ to LE	3.3 5.0	5.5 4.0	-0.5 -0.4		6.0 4.5		ns	3
$t_h$	Hold time $D_n$ to LE	3.3 5.0	1.0 1.0	0.3 0.2		1.0 1.0		ns	3

**NOTE:**

1. Voltage range 3.3V is  $V_{CC} = 3.3\text{V} \pm 0.3\text{V}$   
Voltage range 5.0V is  $V_{CC} = 5.0\text{V} \pm 0.5\text{V}$

**AC CHARACTERISTICS FOR 74ACT373**GND = 0V;  $t_R = t_F = 2.5\text{ns}$ ;  $C_L = 50\text{pF}$ ;  $R_L = 500\Omega$ ; .

SYMBOL	PARAMETER	$V_{CC}^1$ (V)	LIMITS					UNIT	WAVEFORM
			$T_{amb} = +25^\circ\text{C}$			$T_{amb} = -40^\circ\text{C to } +85^\circ\text{C}$			
			MIN	TYP	MAX	MIN	MAX		
$t_{PLH}$	Propagation delay $D_n$ to $Q_n$	5.0	2.0	4.3	10.0	1.5	11.5	ns	2
$t_{PHL}$	Propagation delay $D_n$ to $Q_n$	5.0	2.0	4.9	10.0	1.5	11.5	ns	2
$t_{PLH}$	Propagation delay LE to $Q_n$	5.0	2.0	4.9	10.0	1.5	11.5	ns	1
$t_{PHL}$	Propagation delay LE to $Q_n$	5.0	2.0	4.6	10.0	1.5	11.5	ns	1
$t_{PZH}$	3-State output enable time $\overline{OE}$ to $Q_n$	5.0	2.0	5.2	9.5	1.5	10.5	ns	4
$t_{PZL}$	3-State output enable time $\overline{OE}$ to $Q_n$	5.0	2.0	5.3	9.5	1.5	10.5	ns	4
$t_{PHZ}$	3-State output disable time $\overline{OE}$ to $Q_n$	5.0	2.0	4.9	9.0	1.5	10.0	ns	4
$t_{PLZ}$	3-State output disable time $\overline{OE}$ to $Q_n$	5.0	2.0	4.6	9.0	1.5	10.0	ns	4
$t_w$	LE pulse width HIGH	5.0	5.0	2.0		5.5		ns	1
$t_{su}$	Set up time $D_n$ to LE	5.0	3	-0.8		3		ns	3
$t_h$	Hold time $D_n$ to LE	5.0	2.5	0.8		3		ns	3

**NOTE:**

1. These values are at  $V_{CC} = 5.0\text{V} \pm 0.5\text{V}$

# Octal D-type transparent latch (3-State)

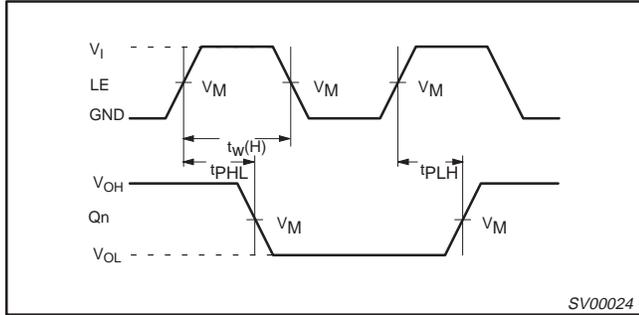
74AC373  
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## AC WAVEFORMS

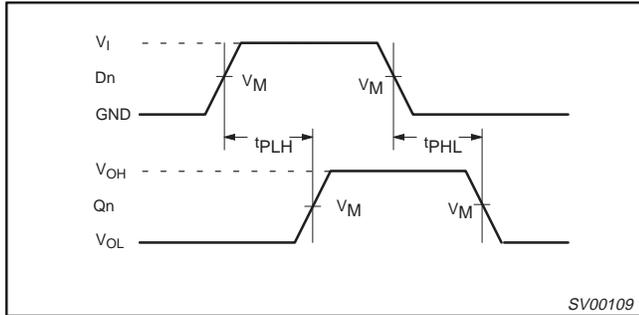
$V_{OL}$  and  $V_{OH}$  are the typical output voltage drops that occur with the output load.

$$V_X = V_{OL} + 0.3V$$

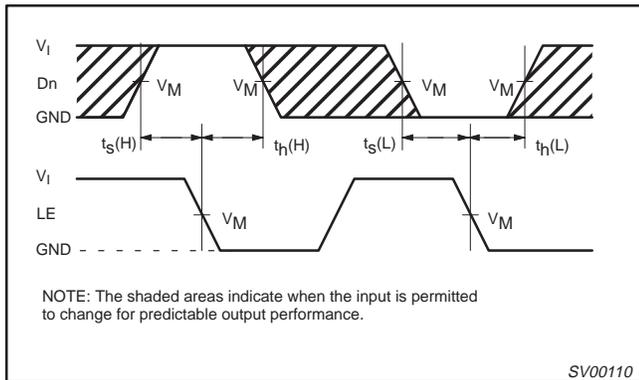
$$V_Y = V_{OH} - 0.3V$$



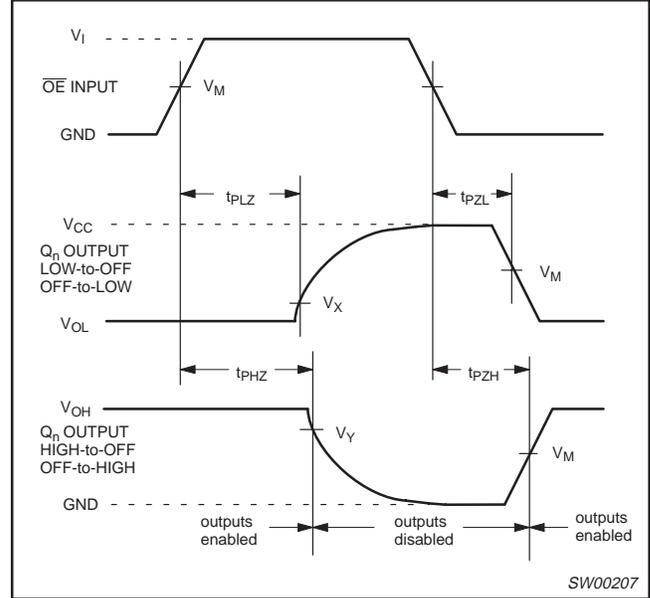
**Waveform 1. Propagation delay, enable to output, and enable pulse width**



**Waveform 2. Propagation delay for data to outputs**



**Waveform 3. Data setup and hold times**

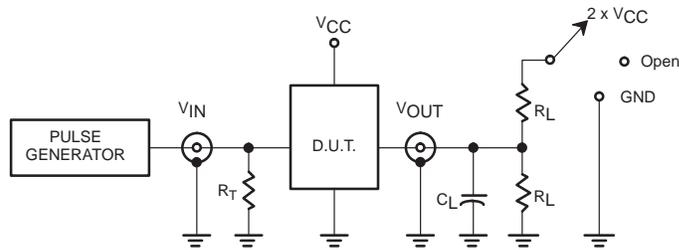


**Waveform 4. Waveforms showing the 3-State output enable and disable times.**

# Octal D-type transparent latch (3-State)

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## TEST CIRCUIT AND WAVEFORM



Test Circuit for 3-State Outputs

### SWITCH POSITION

TEST	SWITCH
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	$2 \times V_{CC}$
$t_{PHZ}/t_{PZH}$	Open

FAMILY	$V_I$ Input Requirements	$V_m$ Input	$V_m$ Output
AC	GND to $V_{CC}$	50% $V_{CC}$	50% $V_{CC}$
ACT	GND to 3.0V	1.5V	50% $V_{CC}$

### DEFINITIONS

$R_L$  = Load resistor; see AC CHARACTERISTICS for value.

$C_L$  = Load capacitance, see AC characteristics

$R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

SV00451

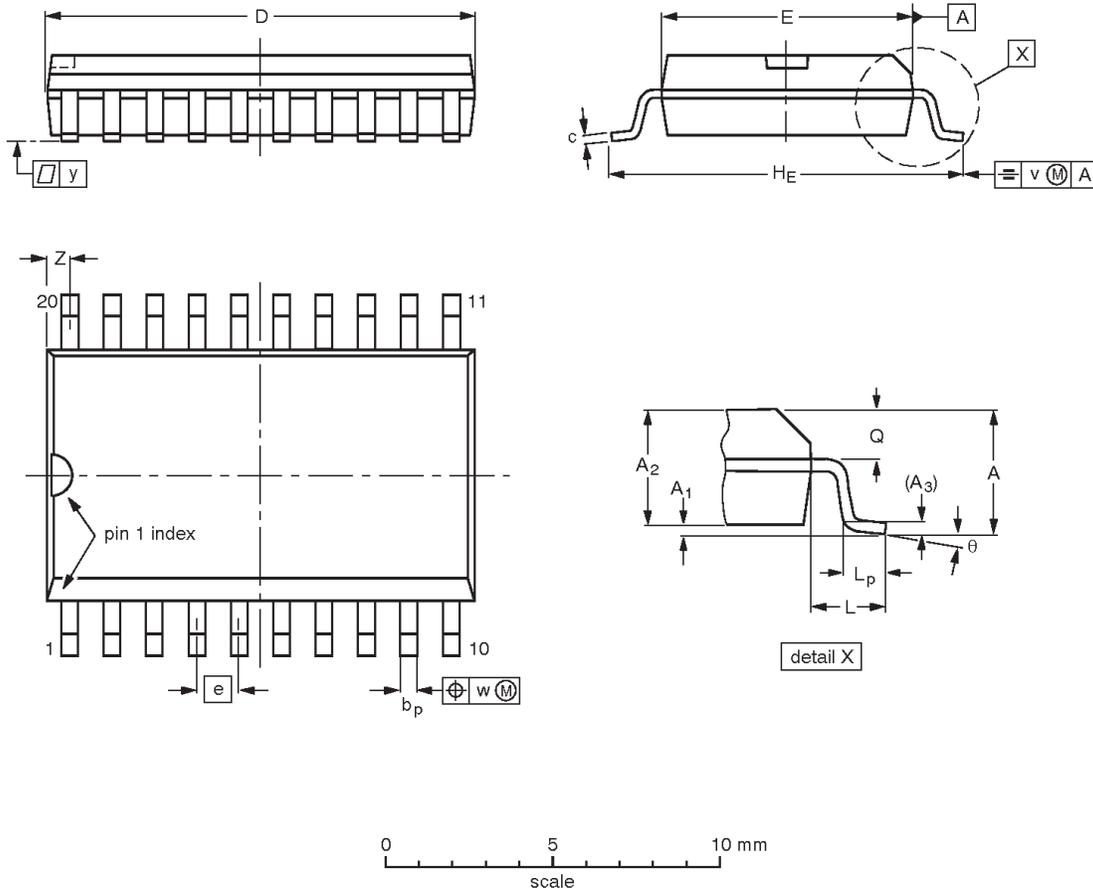
Waveform 5. Load circuitry for switching times.

# Octal D-type transparent latch (3-State)

74AC373  
74ACT373

SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



**DIMENSIONS (inch dimensions are derived from the original mm dimensions)**

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	Z <sup>(1)</sup>	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8° 0°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.050	0.42 0.39	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	

**Note**

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

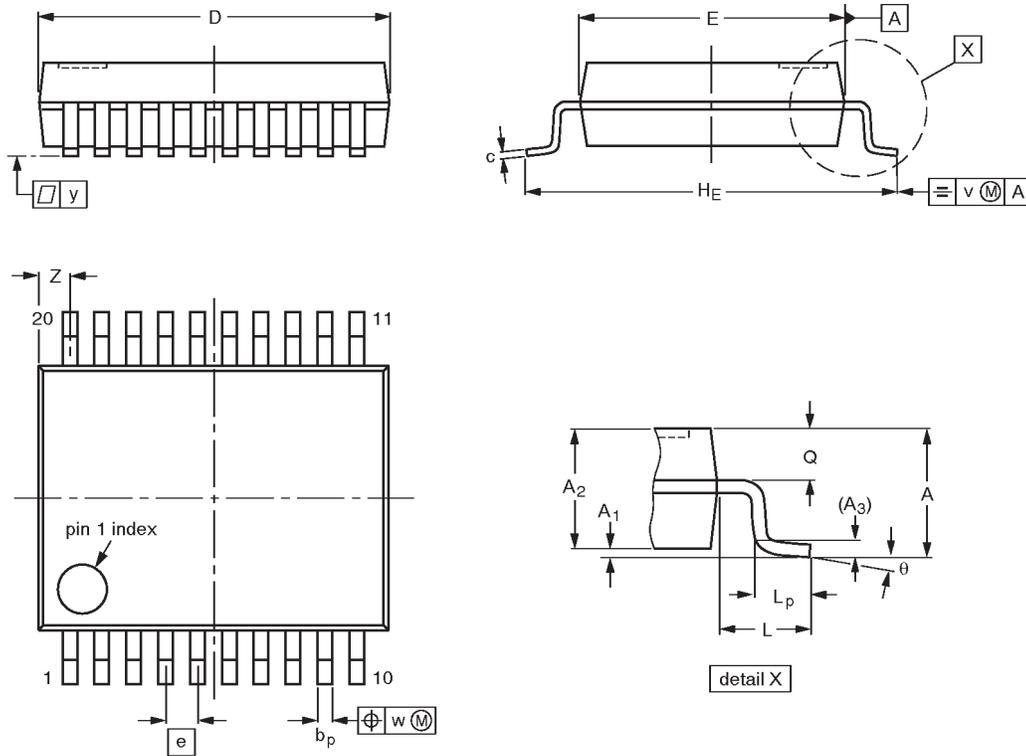
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT163-1	075E04	MS-013AC				92-11-17 95-01-24

# Octal D-type transparent latch (3-State)

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SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1



**DIMENSIONS (mm are the original dimensions)**

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	Z <sup>(1)</sup>	θ
mm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	7.4 7.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.9 0.5	8° 0°

**Note**

1. Plastic or metal protrusions of 0.20 mm maximum per side are not included.

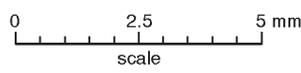
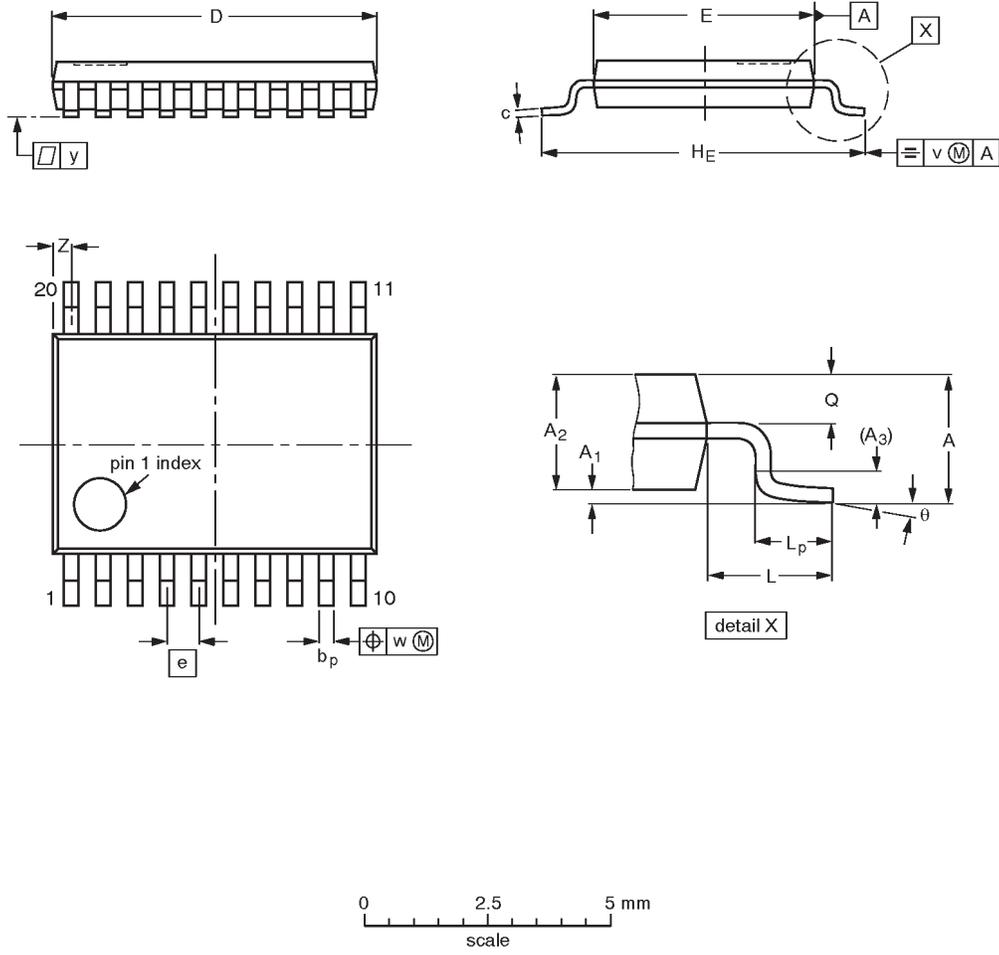
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT339-1		MO-150AE				93-09-08 95-02-04

Octal D-type transparent latch (3-State)

74AC373  
74ACT373

TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(2)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	Z <sup>(1)</sup>	θ
mm	1.10	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	6.6 6.4	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT360-1		MO-153AC				-93-06-16- 95-02-04

## Octal D-type transparent latch (3-State)

74AC373  
74ACT373

## DEFINITIONS

Data Sheet Identification	Product Status	Definition
<i>Objective Specification</i>	<b>Formative or in Design</b>	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
<i>Preliminary Specification</i>	<b>Preproduction Product</b>	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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